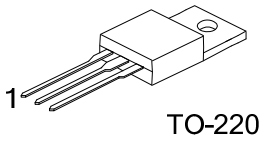
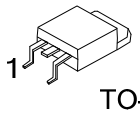
35A, 60V N-CHANNEL POWER MOSFET



TO-220



TO-252

■ DESCRIPTION

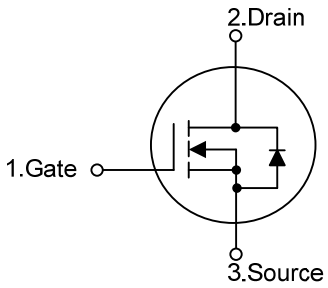
The UTC **UT35N06** is a N-channel enhancement MOSFET using UTC's advanced technology to provide the customers with perfect $R_{DS(ON)}$ and high switching speed.

The UTC **UT60N06** is suitable for all commercial-industrial applications at power dissipation levels to approximately 50 watts, etc.

■ FEATURES

* $R_{DS(ON)}$ ≤ 15mΩ @ V_{GS}=10V, I_D=15A
  $R_{DS(ON)}$ ≤ 23mΩ @ V_{GS}=4.5V, I_D=15A
* High Switching Speed

■ SYMBOL



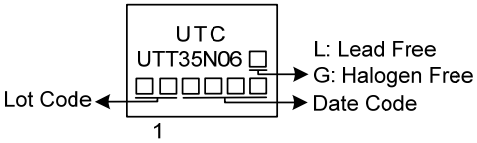
■ ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
UT35N06L-TA3-T	UT35N06G-TA3-T	TO-220	G	D	S	Tube
UT35N06L-TN3-R	UT35N06G-TN3-R	TO-252	G	D	S	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source

UTT35N06G-TA3-T (1)Packing Type (2)Package Type (3)Green Package	(1) T: Tube, R: Tape Reel (2) TA3: TO-220, TN3: TO-252 (3) G: Halogen Free and Lead Free, L: Lead Free

■ MARKING



■ ABSOLUTE MAXIMUM RATING (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	60	V
Gate-Source Voltage		V_{GSS}	±20	V
Drain Current	Continuous	I_D	35	A
	Pulsed (Note 2)	I_{DM}	70	A
Power Dissipation	TO-220	P_D	100	W
	TO-252		46	W
Junction Temperature		T_J	+150	°C
Storage Temperature Range		T_{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
2. Repetitive Rating: Pulse width limited by maximum junction temperature.

■ THERMAL CHARACTERISTICS

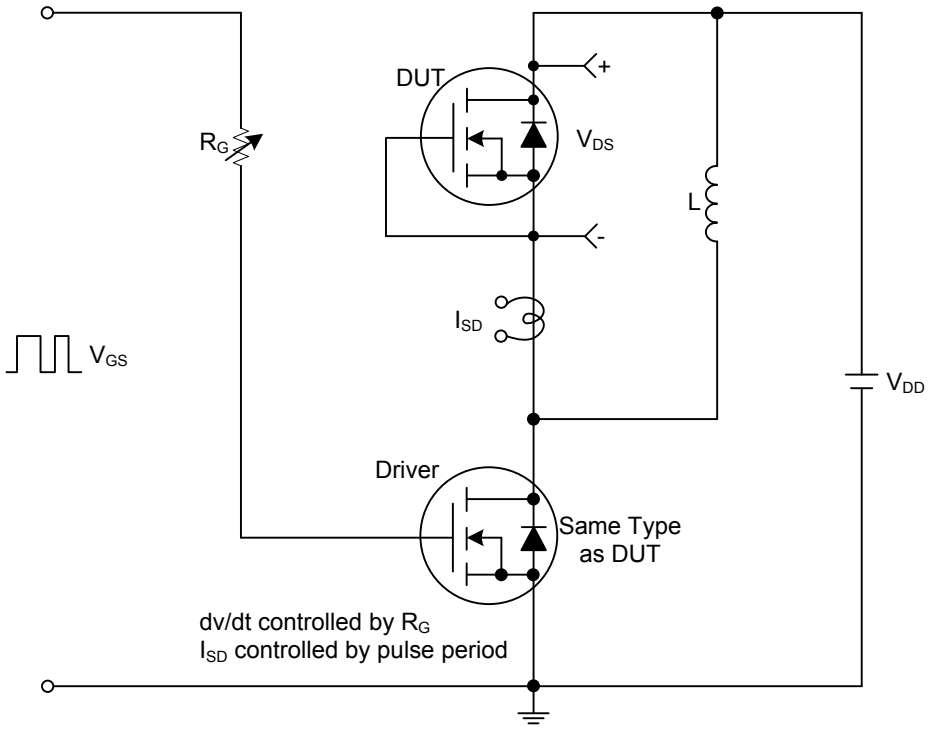
PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient	TO-220	θ_{JA}	62.5	°C/W
	TO-252		100	°C/W
Junction to Case	TO-220	θ_{JC}	1.24	°C/W
	TO-252		2.7	°C/W

■ ELECTRICAL CHARACTERISTICS (T_J =25°C, unless otherwise specified)

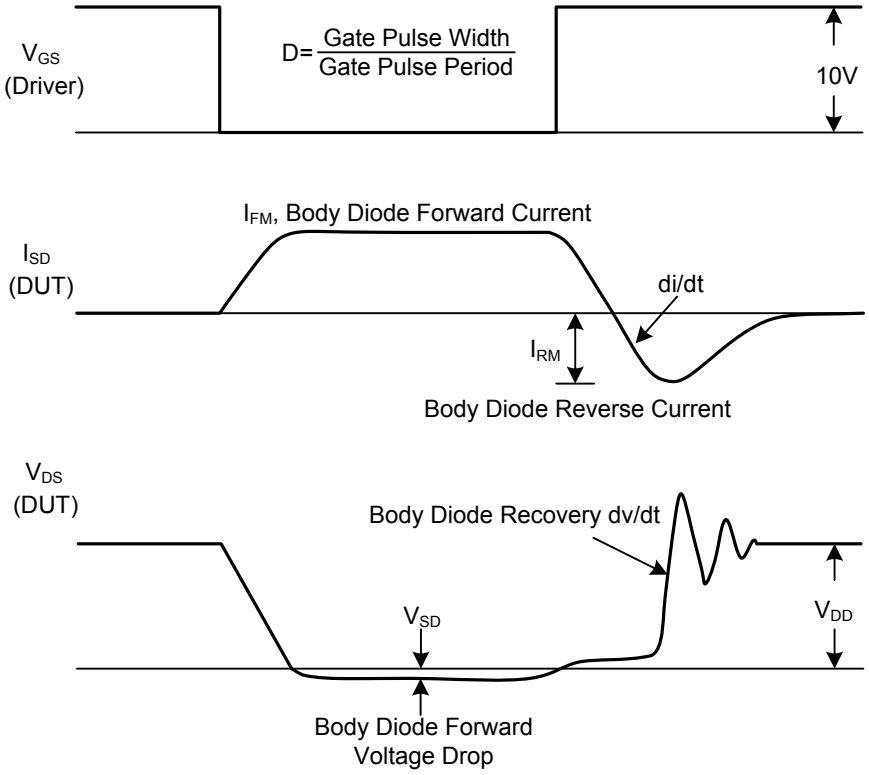
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV_{DSS}	I_D=250μA, V_{GS}=0V	60			V
Drain-Source Leakage Current		I_{DSS}	V_{DS}=60V, V_{GS}=0V			1	μA
Gate-Source Leakage Current	Forward	I_{GSS}	V_{GS}=+20V, V_{DS}=0V			+100	nA
	Reverse		V_{GS}=-20V, V_{DS}=0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	V_{DS}=V_{GS}, I_D=250μA	1.0		3.0	V
Static Drain-Source On-State Resistance		$R_{DS(ON)}$	V_{GS}=10V, I_D=15A			15	mΩ
			V_{GS}=4.5V, I_D=15A			23	mΩ
DYNAMIC PARAMETERS							
Input Capacitance		C_{ISS}	V_{GS}=0V, V_{DS}=25V, f=1.0MHz		1620		pF
Output Capacitance		C_{OSS}			180		pF
Reverse Transfer Capacitance		C_{RSS}			120		pF
SWITCHING PARAMETERS							
Total Gate Charge (Note 1)		Q_G	V_{DS}=30V, V_{GS}=10V, I_D=35A, I_G=1mA (Note 1, 2)		36		nC
Gate to Source Charge		Q_{GS}			4.5		nC
Gate to Drain Charge		Q_{GD}			7		nC
Turn-on Delay Time (Note 1)		$t_{D(ON)}$	V_{DD}=30V, V_{GS}=10V, I_D=1A, R_G =3Ω (Note 1, 2)		7		ns
Rise Time		t_R			15		ns
Turn-off Delay Time		$t_{D(OFF)}$			63		ns
Fall-Time		t_F			42		ns
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS							
Maximum Body-Diode Continuous Current		I_S				35	A
Maximum Body-Diode Pulsed Current		I_{SM}				70	A
Drain-Source Diode Forward Voltage (Note 1)		V_{SD}	I_S=17.5A, V_{GS}=0V			1.4	V
Reverse Recovery Time (Note 1)		t_{rr}	I_S=17.5A, V_{GS}=0V, dI_F/dt =100A/μs		30		nS
Reverse Recovery Charge		Q_{rr}			16		nC

Notes: 1. Pulse Test : Pulse width ≤ 300μs, Duty cycle ≤ 2%.
2. Essentially independent of operating ambient temperature.

■ TEST CIRCUITS AND WAVEFORMS



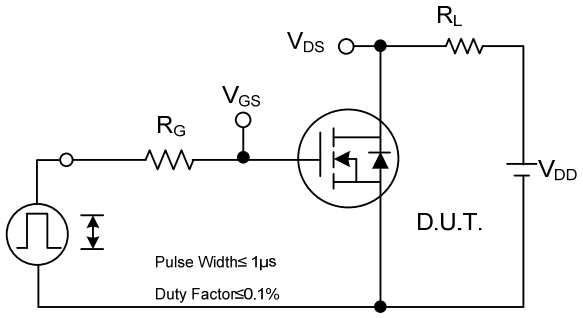
Peak Diode Recovery dv/dt Test Circuit



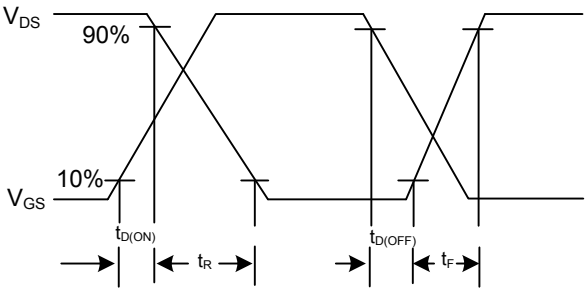
Peak Diode Recovery dv/dt Test Circuit and Waveforms

Peak Diode Recovery dv/dt Waveforms

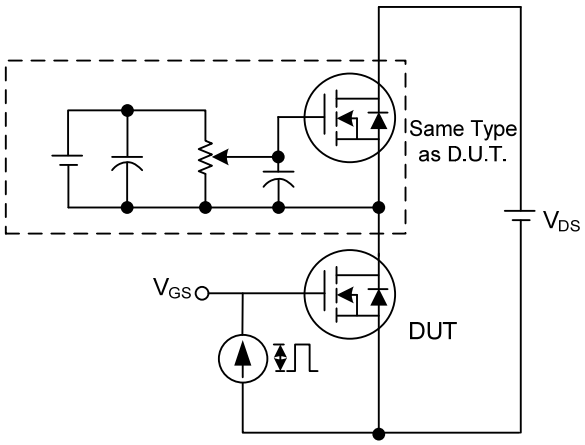
■ TEST CIRCUITS AND WAVEFORMS



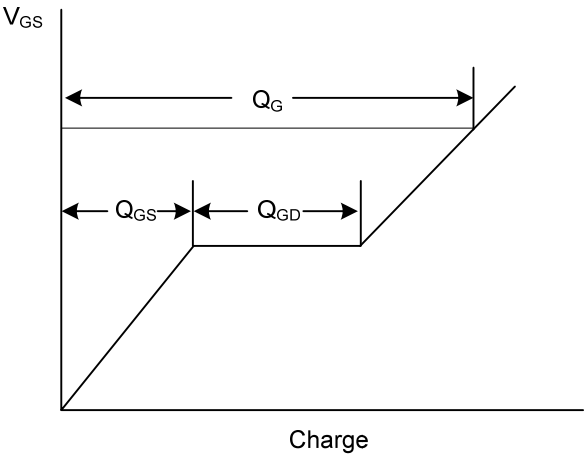
Switching Test Circuit



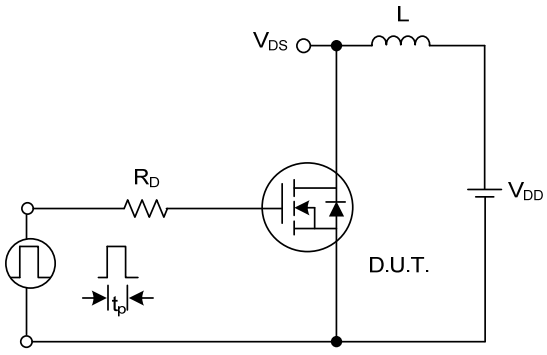
Switching Waveforms



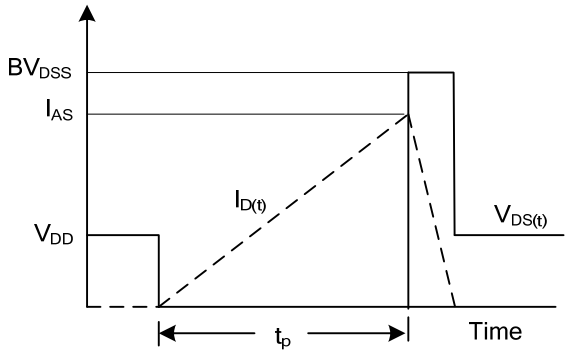
Gate Charge Test Circuit



Gate Charge Waveform



Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms